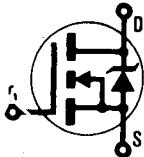


**INTERNATIONAL RECTIFIER** **IR**

## REPETITIVE AVALANCHE RATED AND $dv/dt$ RATED

# HEXFET® TRANSISTOR

# IRFV360



## N-CHANNEL

## 400 Volt, 0.20 Ohm HEXFET

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies and virtually any application where military and/or high reliability is required.

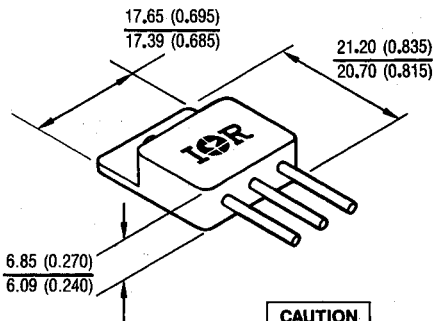
## Product Summary

| Part Number | $V_{DSS}$ | $R_{DS(on)}$  | $I_D$ |
|-------------|-----------|---------------|-------|
| IRFV360     | 400V      | 0.20 $\Omega$ | 25A   |

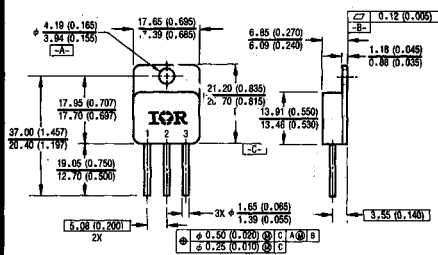
## FEATURES:

- Repetitive Avalanche Rating
- Dynamic dv/dt Rating
- Isolated and Hermetically Sealed
- Alternative to TO-3 Package
- Simple Drive Requirements
- Ease of Paralleling
- Ceramic Everts

## CASE STYLE AND DIMENSIONS



**BERYLLIA WARNING PER MIL-S-19500**  
**SEE PAGE I-462**



**NOTES:**

- NOTES:  
1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M - 1982.  
2 ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).

\*For optional leadforms see page I-462, fig. 15

**Conforms to JEDEC Outline TO-258AA\***  
**Dimensions in Millimeters and (Inches)**

**LEGEND:**

- 1 DRAIN  
2 SOURCE  
3 GATE

## Absolute Maximum Ratings

| Parameter                                                             | IRFV360                                    | Units      |
|-----------------------------------------------------------------------|--------------------------------------------|------------|
| $I_D$ @ $V_{GS} = 10V$ , $T_C = 25^\circ C$ Continuous Drain Current  | 25                                         | A          |
| $I_D$ @ $V_{GS} = 10V$ , $T_C = 100^\circ C$ Continuous Drain Current | 16                                         |            |
| $I_{DM}$ Pulsed Drain Current ①                                       | 100                                        |            |
| $P_D$ @ $T_C = 25^\circ C$ Max. Power Dissipation                     | 300                                        | W          |
| Linear Derating Factor                                                | 2.4                                        | W/K ⑤      |
| $V_{GS}$ Gate-to-Source Voltage                                       | $\pm 20$                                   | V          |
| $E_{AS}$ Single Pulse Avalanche Energy ②                              | 980                                        | mJ         |
| $I_{AR}$ Avalanche Current ①                                          | 25                                         | A          |
| $E_{AR}$ Repetitive Avalanche Energy ①                                | 30                                         | mJ         |
| $dv/dt$ Peak Diode Recovery $dv/dt$ ③                                 | 4.0                                        | V/ns       |
| $T_J$ Operating Junction Temperature                                  | -55 to 150                                 | $^\circ C$ |
| $T_{STG}$ Storage Temperature Range                                   |                                            |            |
| Lead Temperature                                                      | 300 (0.063 in. (1.6 mm) from case for 10s) |            |
| Weight                                                                | 10.9 (typical)                             | g          |

Electrical Characteristics @  $T_J = 25^\circ C$  (Unless Otherwise Specified)

| Parameter                                                                 | Min. | Typ. | Max. | Units    | Test Conditions                                                                    |                                                                                                                                                 |  |
|---------------------------------------------------------------------------|------|------|------|----------|------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------|--|
| $BV_{DSS}$ Drain-to-Source Breakdown Voltage                              | 400  | —    | —    | V        | $V_{GS} = 0V$ , $I_D = 1.0$ mA                                                     |                                                                                                                                                 |  |
| $\Delta BV_{DSS}/\Delta T_J$ Temperature Coefficient of Breakdown Voltage | —    | 0.48 | —    | V/°C     | Reference to 25°C, $I_D = 1.0$ mA                                                  |                                                                                                                                                 |  |
| $R_{DS(on)}$ Static Drain-to-Source On-State Resistance                   | —    | —    | 0.20 | $\Omega$ | $V_{GS} = 10V$ , $I_D = 16A$ ④                                                     |                                                                                                                                                 |  |
|                                                                           | —    | —    | 0.23 |          | $V_{GS} = 10V$ , $I_D = 25A$                                                       |                                                                                                                                                 |  |
| $V_{GS(th)}$ Gate Threshold Voltage                                       | 2.0  | —    | 4.0  | V        | $V_{DS} = V_{GS}$ , $I_D = 250$ $\mu A$                                            |                                                                                                                                                 |  |
| $g_{fs}$ Forward Transconductance                                         | 14   | —    | —    | S (④)    | $V_{DS} \geq 15V$ , $I_{DS} = 16A$ ④                                               |                                                                                                                                                 |  |
| $I_{DSS}$ Zero Gate Voltage Drain Current                                 | —    | —    | 25   | $\mu A$  | $V_{DS} = 0.8 \times \text{Max. Rating}$ , $V_{GS} = 0V$                           |                                                                                                                                                 |  |
|                                                                           | —    | —    | 250  |          | $V_{DS} = 0.8 \times \text{Max. Rating}$                                           |                                                                                                                                                 |  |
|                                                                           | —    | —    | —    |          | $V_{GS} = 0V$ , $T_J = 125^\circ C$                                                |                                                                                                                                                 |  |
| $I_{GSS}$ Gate-to-Source Leakage Forward                                  | —    | —    | 100  | nA       | $V_{GS} = 20V$                                                                     |                                                                                                                                                 |  |
| $I_{GSS}$ Gate-to-Source Leakage Reverse                                  | —    | —    | -100 |          | $V_{GS} = -20V$                                                                    |                                                                                                                                                 |  |
| $Q_g$ Total Gate Charge                                                   | —    | —    | 210  | nC       | $V_{GS} = 10V$ , $I_D = 25A$                                                       |                                                                                                                                                 |  |
| $Q_{gs}$ Gate-to-Source Charge                                            | —    | —    | 28   |          | $V_{DS} = 0.5 \times \text{Max. Rating}$                                           |                                                                                                                                                 |  |
| $Q_{gd}$ Gate-to-Drain ("Miller") Charge                                  | —    | —    | 120  |          | See Fig. 6 and 14                                                                  |                                                                                                                                                 |  |
| $t_{d(on)}$ Turn-On Delay Time                                            | —    | —    | 33   | ns       | $V_{DD} = 200V$ , $I_D = 25A$ , $R_G = 2.35\Omega$                                 |                                                                                                                                                 |  |
| $t_r$ Rise Time                                                           | —    | —    | 140  |          | See Fig. 11                                                                        |                                                                                                                                                 |  |
| $t_{d(off)}$ Turn-Off Delay Time                                          | —    | —    | 120  |          |                                                                                    |                                                                                                                                                 |  |
| $t_f$ Fall Time                                                           | —    | —    | 99   |          |                                                                                    |                                                                                                                                                 |  |
| $L_D$ Internal Drain Inductance                                           | —    | 8.7  | —    | nH       | Measured from the drain lead, 6 mm (0.25 in.) from package to center of die.       | Modified MOSFET symbol showing the internal inductances.<br> |  |
| $L_S$ Internal Source Inductance                                          | —    | 8.7  | —    |          | Measured from the source lead, 6 mm (0.25 in.) from package to source bonding pad. |                                                                                                                                                 |  |
| $C_{iss}$ Input Capacitance                                               | —    | 4200 | —    | pF       | $V_{GS} = 0V$ , $V_{DS} = 25V$                                                     |                                                                                                                                                 |  |
| $C_{oss}$ Output Capacitance                                              | —    | 900  | —    |          | $f = 1.0$ MHz                                                                      |                                                                                                                                                 |  |
| $C_{rss}$ Reverse Transfer Capacitance                                    | —    | 400  | —    |          | See Fig. 5                                                                         |                                                                                                                                                 |  |
| $C_{DC}$ Drain-to-Case Capacitance                                        | —    | 12   | —    |          | $f = 1.0$ MHz                                                                      |                                                                                                                                                 |  |



## Source-Drain Diode Ratings and Characteristics

| Parameter                                     | Min.                                                                                             | Typ. | Max. | Units         | Test Conditions                                                                                                                                               |
|-----------------------------------------------|--------------------------------------------------------------------------------------------------|------|------|---------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$ Continuous Source Current (Body Diode)  | —                                                                                                | —    | 25   | A             | Modified MOSFET symbol showing the integral Reverse p-n junction rectifier.  |
| $I_{SM}$ Pulsed Source Current (Body Diode) ① | —                                                                                                | —    | 100  |               |                                                                                                                                                               |
| $V_{SD}$ Diode Forward Voltage                | —                                                                                                | —    | 1.8  | V             | $T_J = 25^\circ\text{C}$ , $I_S = 25\text{A}$ , $V_{GS} = 0\text{V}$ ④                                                                                        |
| $t_{rr}$ Reverse Recovery Time                | —                                                                                                | —    | 1000 | nS            | $T_J = 25^\circ\text{C}$ , $I_F = 25\text{A}$ , $dI/dt \leq 100\text{ A}/\mu\text{s}$ ④                                                                       |
| $Q_{RR}$ Reverse Recovery Charge              | —                                                                                                | —    | 16   | $\mu\text{C}$ | $V_{DD} \leq 50\text{V}$                                                                                                                                      |
| $t_{on}$ Forward Turn-On Time                 | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ . |      |      |               |                                                                                                                                                               |

## Thermal Resistance

| Parameter                      | Min. | Typ. | Max. | Units | Test Conditions                            |
|--------------------------------|------|------|------|-------|--------------------------------------------|
| $R_{thJC}$ Junction-to-Case    | —    | —    | 0.42 | K/W ⑤ |                                            |
| $R_{thCS}$ Case-to-Sink        | —    | 0.21 | —    |       | Mounting surface flat, smooth, and greased |
| $R_{thJA}$ Junction-to-Ambient | —    | —    | 30   |       | Typical socket mount                       |

① Repetitive Rating: Pulse width limited by maximum junction temperature (see figure 9)  
Refer to current HEXFET reliability report

② @  $V_{DD} = 50\text{V}$ , Starting  $T_J = 25^\circ\text{C}$ ,  
 $L \geq 2.7\text{ mH}$ ,  $R_G = 25\Omega$ ,  
Peak  $I_L = 25\text{A}$

③  $I_{SD} \leq 25\text{A}$ ,  $dI/dt \leq 170\text{ A}/\mu\text{s}$ ,  
 $V_{DD} \leq BV_{DSS}$ ,  $T_J \leq 150^\circ\text{C}$   
Suggested  $R_G = 2.35\Omega$

④ Pulse width  $\leq 300\text{ }\mu\text{s}$ ; Duty Cycle  $\leq 2\%$

⑤  $K/W = ^\circ\text{C}/W$   
 $W/K = W/^\circ\text{C}$



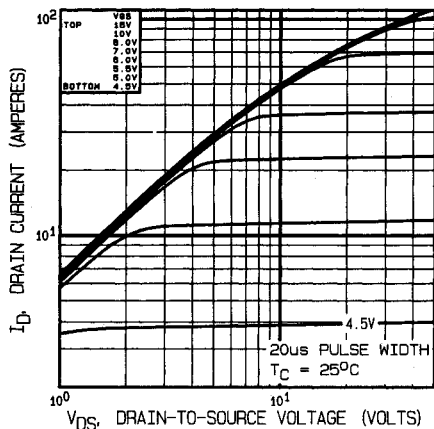
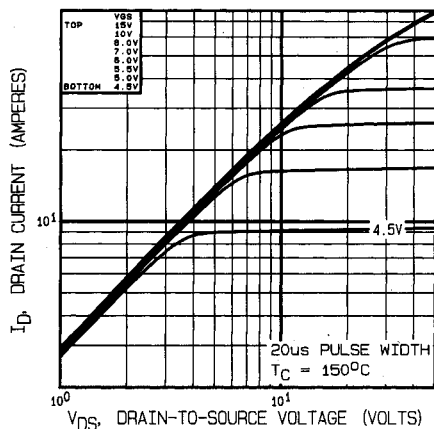
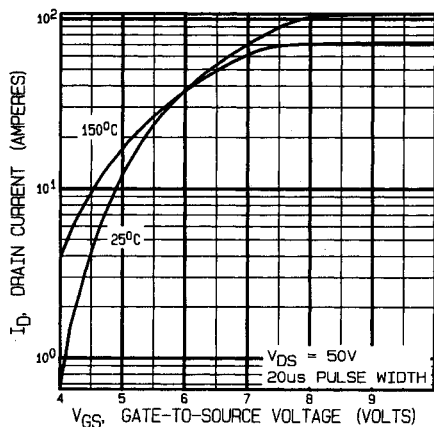
Fig. 1 — Typical Output Characteristics,  $T_C = 25^\circ\text{C}$ Fig. 2 — Typical Output Characteristics,  $T_C = 150^\circ\text{C}$ 

Fig. 3 — Typical Transfer Characteristics

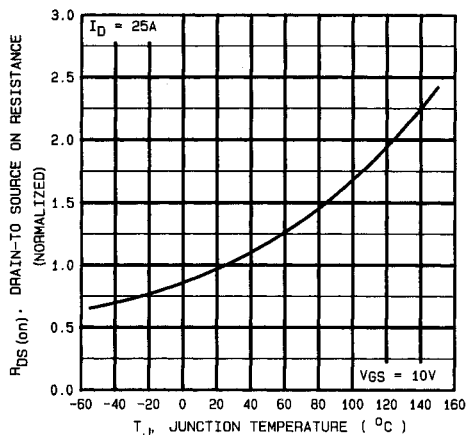
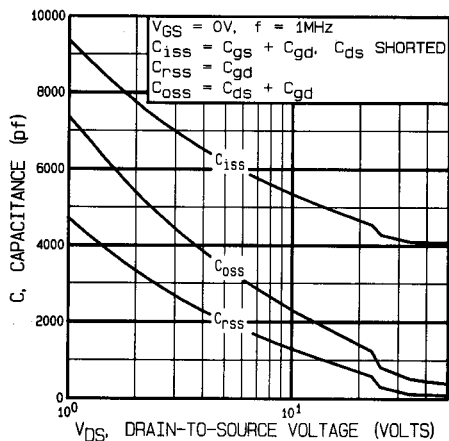
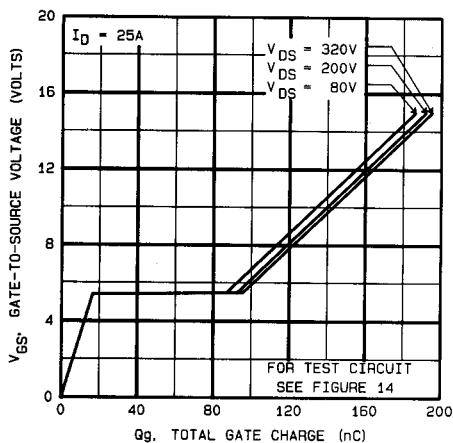
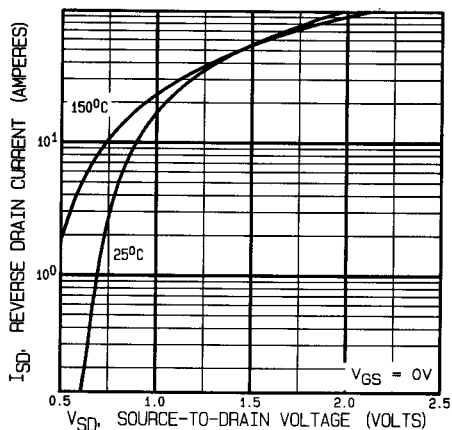
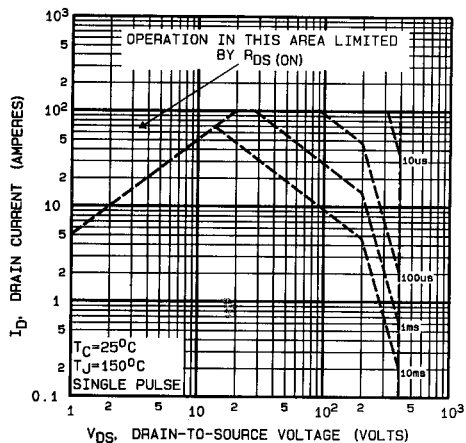


Fig. 4 — Normalized On-Resistance Vs. Temperature


**Fig. 5 — Typical Capacitance Vs. Drain-to-Source Voltage**

**Fig. 6 — Typical Gate Charge Vs. Gate-to-Source Voltage**

**Fig. 7 — Typical Source-Drain Diode Forward Voltage**

**Fig. 8 — Maximum Safe Operating Area**

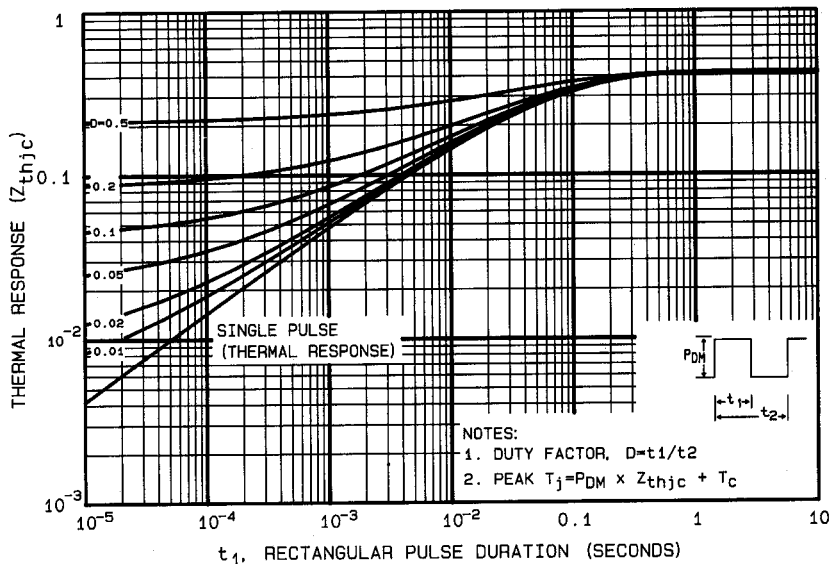


Fig. 9 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

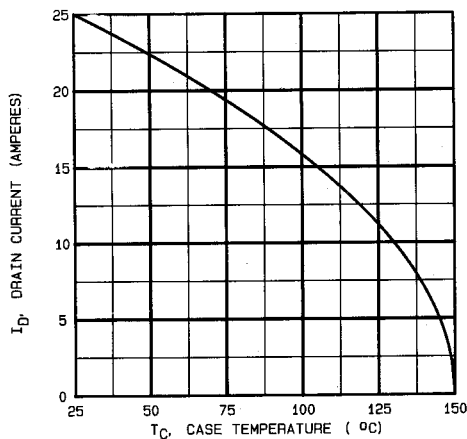


Fig. 10 — Maximum Drain Current Vs. Case Temperature

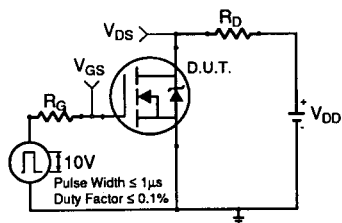


Fig. 11a — Switching Time Test Circuit

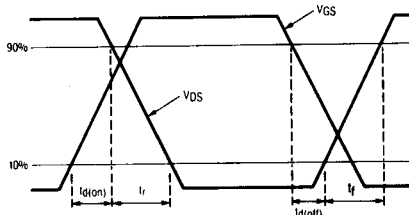
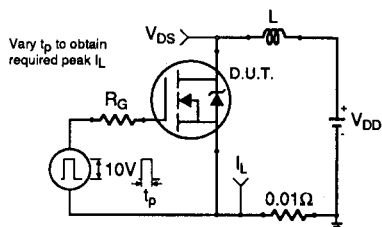
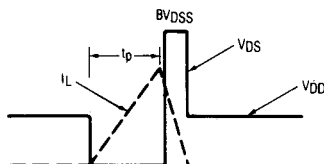
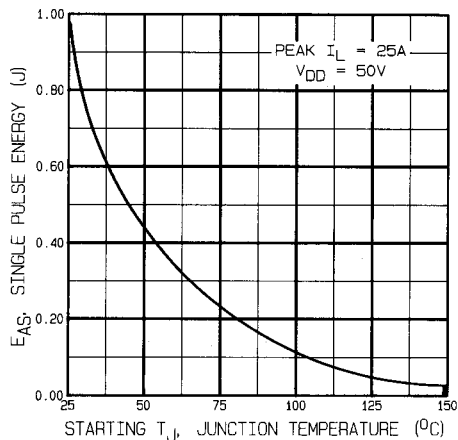
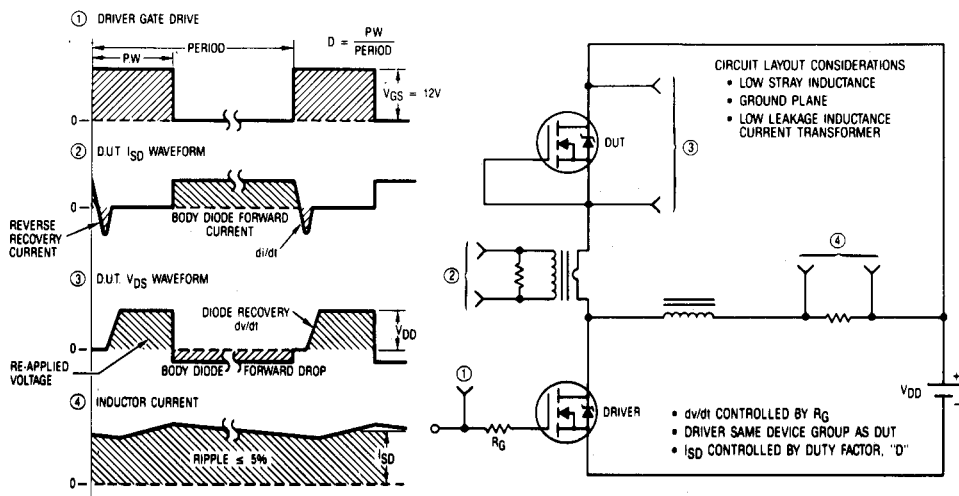


Fig. 11b — Switching Time Waveforms


**Fig. 12a — Unclamped Inductive Test Circuit**

**Fig. 12b — Unclamped Inductive Waveforms**

**Fig. 12c — Maximum Avalanche Energy Vs. Starting Junction Temperature**

**Fig. 13 — Peak Diode Recovery  $dv/dt$  Test Circuit**

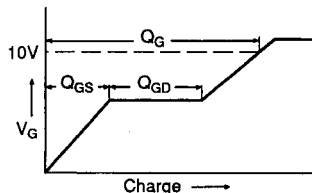


Fig. 14a — Basic Gate Charge Waveform

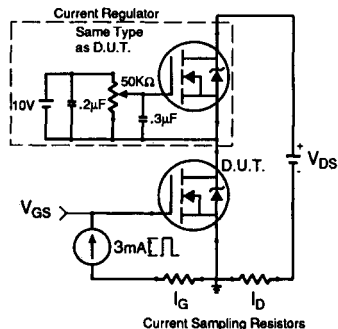


Fig. 14b — Gate Charge Test Circuit

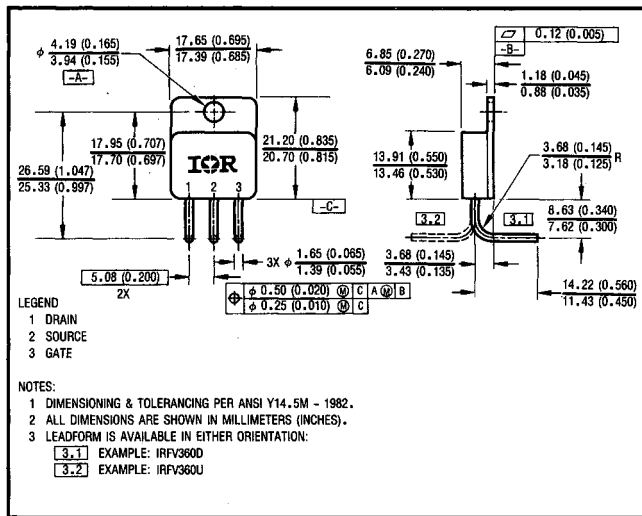


Fig. 15 — Optional Leadforms for Outline TO-258

## BERYLLIA WARNING PER MIL-S-19500

Packages containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.